

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 242603US2SRD		SERIAL NO. <u>10/65797</u> New Application	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Tadashi SAKAI, et al.			
				FILING DATE Herewith		GROUP <u>2879</u>	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>JN</i>	AA	6,469,425 B1	10/22/02	Tadashi SAKAI, et al.	←		
	AB						
	AC						
	AD						
	AE						
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	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
<i>JN</i>	AO	4-274156	09/30/92	Japan		X	
<i>JN</i>	AP	8-236083	09/13/96	Japan		X	
<i>JN</i>	AQ	2002-117771	04/19/02	Japan		X	
<i>JN</i>	AR	2002-298777	10/11/02	Japan		X	
<i>JN</i>	AS	2003-132850	05/09/03	Japan		X	
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
<i>JN</i>	AW	M. STAMMLER, et al., "FIELD EMISSION MEASUREMENTS WITH MICROMETRE RESOLUTION ON CARBON NANOSTRUCTURES", Diamond and Related Materials, Vol 8 (1999), pgs. 792 - 797. <i>no month</i>					
<i>JN</i>	AX	Ken OKANO, et al., "LOW-THRESHOLD COLD CATHODES MADE OF NITROGEN-DOPED CHEMICAL-VAPOUR-DEPOSITED DIAMOND", Nature, Vol 381, May 9, 1996, pgs. 140 - 141.					
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>Joseph W. Allen</i>					Date Considered <i>9/27/05</i>		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							